

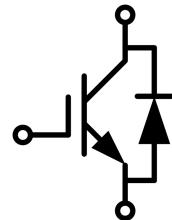
IGBT Discrete with Anti-Parallel Diode

Features :

- 650V Trench /Field Stop type
- Low switching losses
- Vcesat has a positive temperature coefficient



TO-247



Applications:

- Charging station
- Uninterruptible power supplies
- Inverters

IGBT

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Collector-Emitter Voltage	$T_{vj}=25^{\circ}\text{C}$	V_{CES}	650	V
Continuous DC collector current	$T_c=25^{\circ}\text{C}, T_{vj\max}=175^{\circ}\text{C}$ $T_c=100^{\circ}\text{C}, T_{vj\max}=175^{\circ}\text{C}$	I_c	80 75	A
Pulsed collector current, tp limited by $T_{vj\max}$		I_{Cpuls}	225	A
Total power dissipation	$T_c=25^{\circ}\text{C}, T_{vj\max}=175^{\circ}\text{C}$ $T_c=100^{\circ}\text{C}, T_{vj\max}=175^{\circ}\text{C}$	P_{tot}	441 220	W

Gate emitter Voltage	$t_p \leqslant 10\mu s, D < 0.010$	V_{GE}	± 20 ± 30	V
Temperature under switching conditions		$T_{vj\ op}$	-40...+175	°C
Storage temperature		T_{stg}	-40...+150	°C

Thermal Characteristics

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Thermal resistance, junction-ambient		$R_{th(j-a)}$			65	K/W
IGBT thermal resistance, junction - case		$R_{th(j-C)}$		0.34		K/W
Diode thermal resistance, junction - case		$R_{th(j-C)}$		0.49		K/W

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Collector-emitter breakdown voltage	$V_{GE}=0V, IC=0.25mA$	$V_{(BR)CES}$	650			
Collector-Emitter saturation Voltage	$V_{GE}=15V, IC=75A$ $V_{GE}=15V, IC=75A$ $V_{GE}=15V, IC=75A$	V_{CEsat}		1.63 2.03 2.13	2.10	V
Gate-Emitter threshold Voltage	$I_C=0.75mA, V_{GE}=V_{CE}$	$T_{vj}=25^{\circ}C$	$V_{GE(th)}$	4.2	5.1	6.0
Transconductance	$V_{CE}=20V, I_C=75A$	G_{fs}		91		S
Input capacitance	$f=1\ MHz, V_{CE}=25V, V_{GE}=0V$	C_{ies}		7.44		nF
Output capacitance		C_{oes}		0.24		
Reverse transfer capacitance		C_{res}		0.13		
Gate charge	$I_C = 75A, V_{GE} = 15V,$ $V_{CE} = 520V$	$T_{vj}=25^{\circ}C$	Q_G		0.74	μC
Collector-emitter cut-off current	$V_{CE}=650V, V_{GE}=0V$	$T_{vj}=25^{\circ}C$ $T_{vj}=175^{\circ}C$	I_{CES}		2400	50
Gate-emitter leakage current	$V_{CE}=0V, V_{GE}=20V$	$T_{vj}=25^{\circ}C$	I_{GES}		100	nA

Turn-on delay time	I _c =75A, V _{CE} =400V V _{GE} =±15V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _{d on}	34 37 40		ns
Rise time	I _c =75A, V _{CE} =400V V _{GE} =±15V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _r	153 157 163		
Turn-off delay time	I _c =75A, V _{CE} =400V V _{GE} =±15V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _{d off}	183 198 208		
Fall time	I _c =75A, V _{CE} =400V V _{GE} =±15V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _f	67 68 73		
Turn-on energy loss per pulse	I _c =75A, V _{CE} =400V V _{GE} =±15V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	E _{on}	4.28 4.35 4.57	mJ	mJ
Turn-off energy loss per pulse	I _c =75A, V _{CE} =400V V _{GE} =±15V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	E _{off}	1.08 1.12 1.20		
Total switching energy	I _c =75A, V _{CE} =400V V _{GE} =±15V, R _G =8Ω (inductive load)	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	E _{ts}	5.36 5.47 5.77		

Diode

Maximum Ratings

Parameter	Conditions	Symbol	Value	Unit
Repetitive peak reverse Voltage	T _{vj} =25°C	V _{RRM}	650	V
Continuous DC forward current	T _C =25°C, T _{vj max} =175°C T _C =100°C, T _{vj max} =175°C	I _F	80 75	A
Diode pulsed current, tp limited by T _{vj max}		I _{Fpuls}	180	A

Characteristic Values

Parameter	Conditions	Symbol	Value			Unit
			Min.	Typ.	Max.	
Forward Voltage	I _F =75A, V _{GE} =0V	V _F		1.48	2.0	V
	I _F =75A, V _{GE} =0V			1.61		
	I _F =75A, V _{GE} =0V			1.62		
Peak reverse recovery current	I _F =75A, -diF/dt=460A/μs(T _{vj} =150°C) V _R =400V, V _{GE} =-15V	I _{RM}		17		A
				23		
				25		

Reverse Recovered charge	I _F =75A, -di _F /dt=460A/μs(T _{vj} =150°C) V _R =400V,V _{GE} =-15V	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	Q _{rr}		2.43 3.37 3.72		μC
Reverse Recovery Time	I _F =75A, -di _F /dt=460A/μs(T _{vj} =150°C) V _R =400V,V _{GE} =-15V	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	t _{rr}		200 211 227		ns
Reverse recovered energy	I _F =75A, -di _F /dt=460A/μs(T _{vj} =150°C) V _R =400V,V _{GE} =-15V	T _{vj} =25°C T _{vj} =125°C T _{vj} =150°C	E _{rec}		0.68 0.91 0.99		mJ

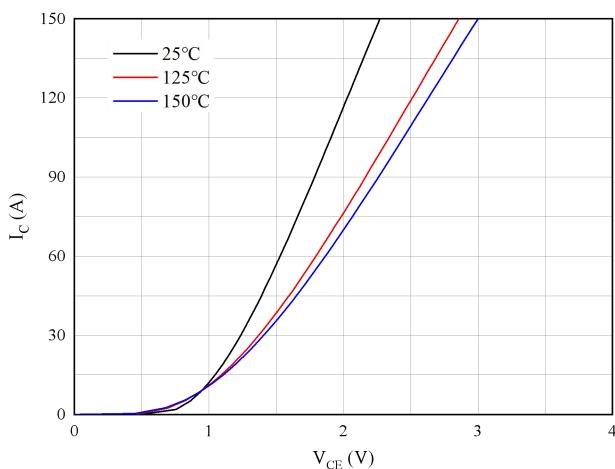


Fig 1. Typical output characteristics ($V_{GE}=15V$)

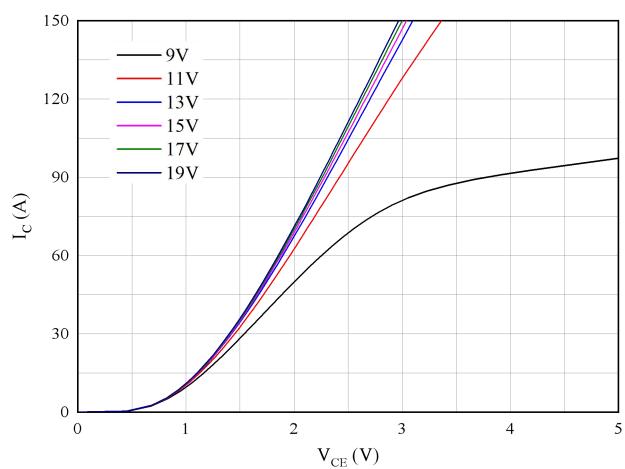


Fig 2. Typical output characteristics ($T_{vj}=150^\circ C$)

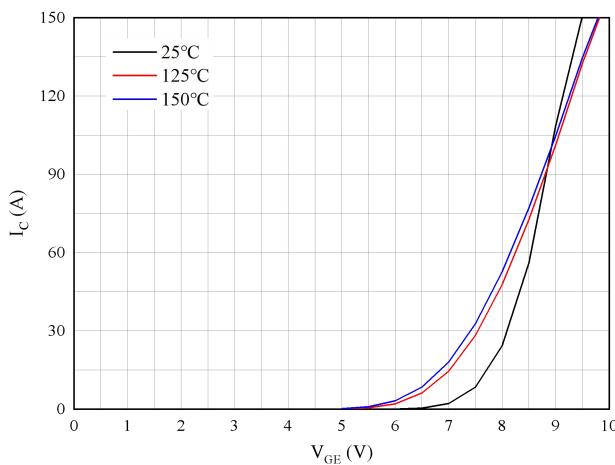


Fig 3. Typical transfer characteristic($V_{CE}=20V$)

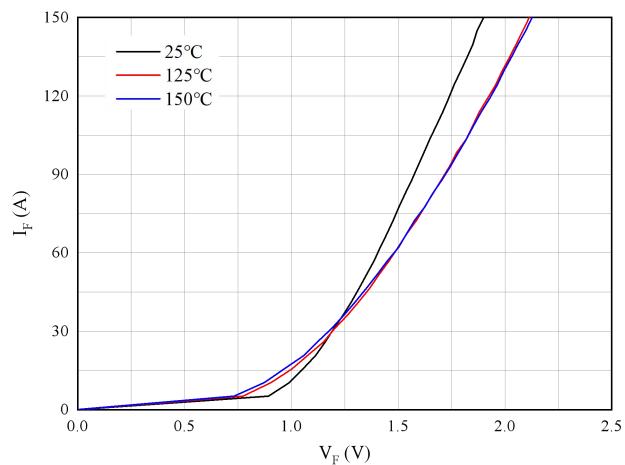


Fig 4. Forward characteristic of Diode

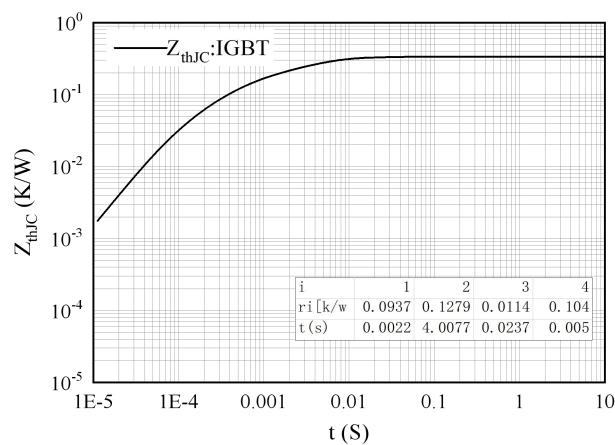


Fig 5. Transient thermal impedance IGBT,
 $Z_{thJC}=f(t)$

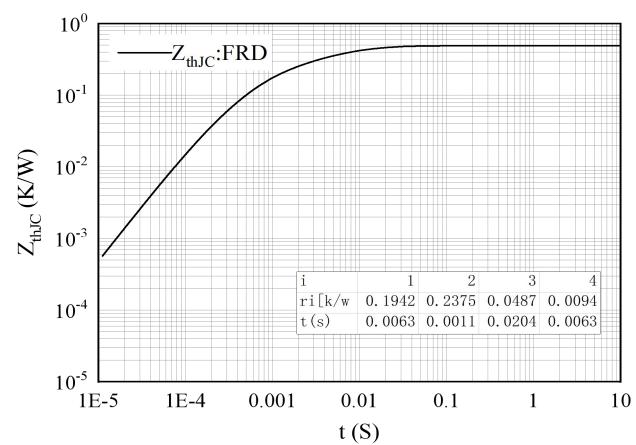


Fig 6. Transient thermal impedance FRD,
 $Z_{thJC}=f(t)$

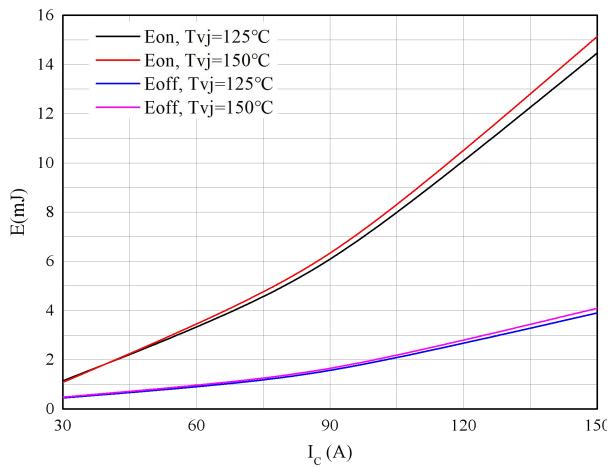


Fig 7. Switching losses of IGBT

VGE = ± 15V, RGon = 8Ω, RGoff = 8Ω, VCE = 400V

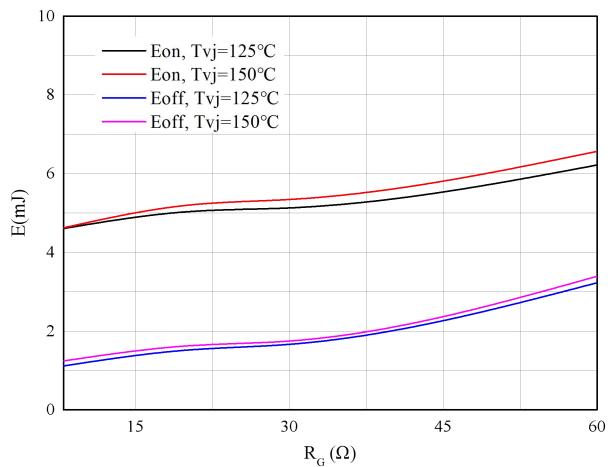


Fig 8. Switching losses of IGBT

VGE = ± 15V, IC = 75A, VCE = 400V

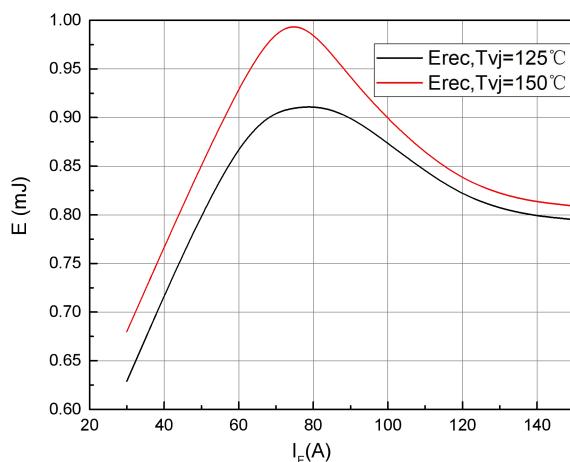


Fig 9. Switching losses of Diode

R_{gon} = 8Ω, VCE = 400V

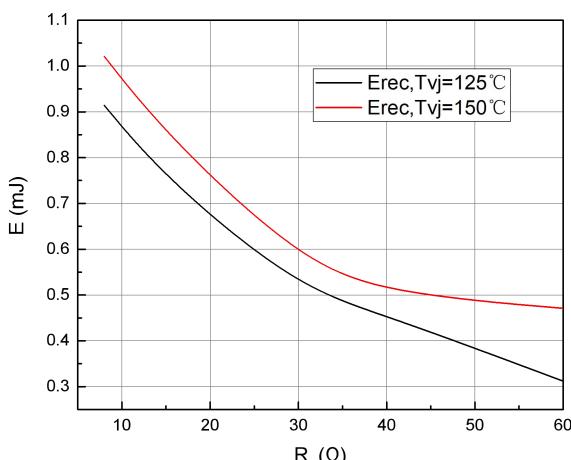


Fig 10. Switching losses of Diode

IF = 75A, VCE = 400V

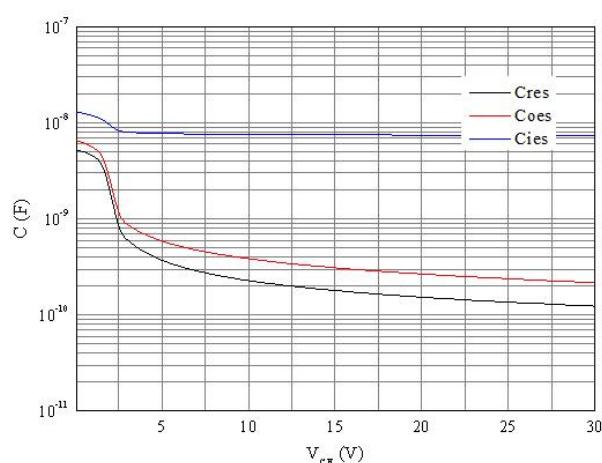
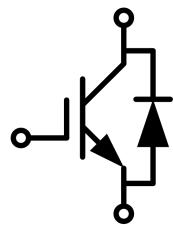
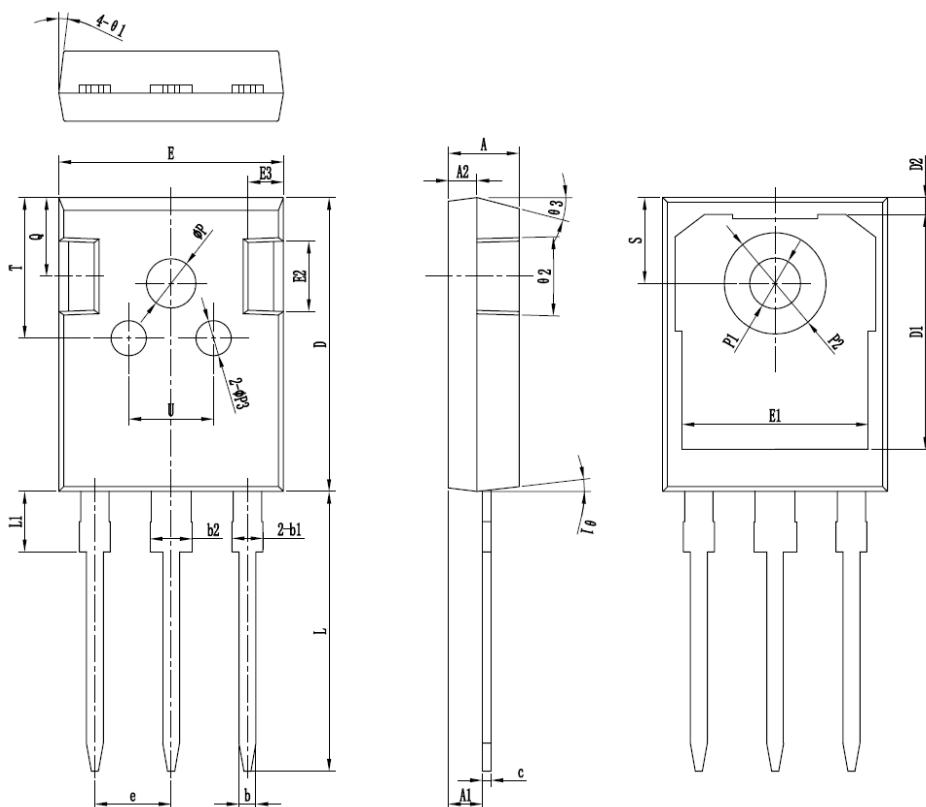


Fig 11. Capacitance characteristic

Circuit diagram

Package outlines


symbol	unit: mm		
	MIN	NOM	MAX
a ₁	4.90	5.00	5.10
a ₁₁	2.31	2.41	2.51
a ₂	1.90	2.00	2.10
a ₃	1.15	1.20	1.25
a ₅₁	1.95	2.10	2.25
a ₅₂	2.95	3.10	3.25
a _c	0.55	0.60	0.65
a _d	20.90	21.00	21.10
D1	16.35	16.55	16.75
D2	1.05	1.20	1.35
e ₅	15.70	15.80	15.90
E1	13.10	13.25	13.40
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
e ₆	5.40	5.44	5.48
a _L	19.80	19.92	20.10
a _{L1}	-	-	4.30
a _{P1}	3.70	3.80	3.90
a _{P1}	3.50	3.60	3.70
a _{P2}	7.00	7.20	7.40
a _{P3}	2.40	2.50	2.60
Q	5.60	5.80	6.00
s ₅	6.05	6.15	6.25
T	9.80	10.00	10.20
U	6.00	6.20	6.40
θ1	5°	7°	9°
θ2	1°	3°	5°
θ3	13°	15°	17°